

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/936,565	SAUK, JOHN J.	
Examiner	Art Unit	
Christopher H. Vaen	1643	

Subclass	Date	Examiner
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TNI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		ATE	EXMR		
Updated searches	10/1	0/2006	CHY		
SEQ ID No: search 9 and 13	10/1	0/2006	СНҮ		
palm inventor search	10/1	0/2006	СНҮ		
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